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APPLICANTS

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** CONTINUING DATA *****

NONE BY

** FOREIGN APPLICATIONS *****

NONE BY

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

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Foreign Priority claimed , 35 USC 119 (a-d) conditions met Verified and Acknowledged	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after Allowance Examiner's Signature _____ Initials _____	STATE OR COUNTRY CA	SHEETS DRAWING 4	TOTAL CLAIMS 22	INDEPENDENT CLAIMS 5
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TITLE

Techniques for measurement of deformation of electronically scanned antenna array structures

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